

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YANASHIMA ET AL.	
		Examiner B. Chen	Art Unit 1762	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,444,811	08-1995	Yoshimura et al.	385/141
	B	US-5,366,766	11-1994	Sekiguchi et al.	427/255.4
	C	US-5,993,542	11-1999	Yanashima et al.	117/84
	D	US-6,337,102	01-2002	Forrest et al.	427/64
	E	US-4,940,854	07-1990	Debe, Mark K.	428/411.1
	F	US-4,773,355	09-1988	Reif et al.	118/719
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.